WNSC2M1K0170B7

N-Channel Silicon Carbide MOSFET

Rev.01 - 19 July 2023 — Product data sheet

1. General description

Silicon Carbide MOSFET in a TO263-7L plastic package, designed for high frequency, high efficiency systems.

RoHS Halogen-Free Lead-Free

2. Features and benefits

- Low on-resistance
- Fast switching speed
- 0V turn-off gate voltage for simple gate drive
- Easy to parallel
- 100% UIS Tested
- Controllable dV/dt for optimized EMI
- Reduced cooling requirements
- RoHS compliant

3. Applications

- Switch Mode Power Supplies
- UPS
- Solar string inverter and solar optimizer
- EV Charger
- Motor Drives

4. Quick reference data

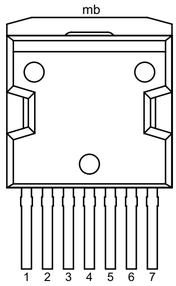
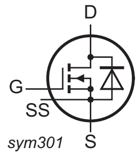
Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Absolute maximum rating							
V_{DS}	drain-source voltage	25 °C ≤ T_j ≤ 175 °C			1700		V
I_D	drain current	V_{GS} = 18 V; T_{mb} = 25 °C			7.5		A
P_{tot}	total power dissipation	T_{mb} = 25 °C			91		W
T_j	junction temperature				-55 to 175		°C
Symbol	**Parameter**	**Conditions**	**Notes**	**Min**	**Typ**	**Max**	**Unit**
Static characteristics							
$R_{DS(on)}$	drain-source on-state resistance	V_{GS} = 15 V; I_D = 1 A; T_j = 25 °C		-	1000	-	mΩ
Dynamic characteristics							
$Q_{G(tot)}$	total gate charge	I_D = 2 A; V_{DS} = 1200 V; V_{GS} = 0 V/18 V; T_j = 25 °C		-	12	-	nC
Q_{GD}	gate-drain charge			-	5	-	nC
Source-drain diode							
Q_r	recovered charge	I_{SD} = 1 A; di/dt = 500 A/µs; V_{DS} = 400 V; T_j = 25 °C		-	38	-	nC

Note: in the Absolute maximum rating rows, Values span Min/Typ/Max columns.

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	 TO263-7L	
2	SS	source sense		
3-7	S	source		
mb	D	mounting base; connected to drain		

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WNSC2M1K0170B7	TO263-7L	WNSC2M1K0170B7J	Reel	800	TO263P-7L	12-Jun-2023

7. Marking

Table 4. Marking codes

Type number	Marking codes
WNSC2M1K0170B7	WNSC2M 1K0170B7

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Vaules	Unit
V_{DS}	drain-source voltage	25 °C ≤ T_j ≤ 175 °C		1700	V
$V_{GS,max}$	gate-source voltage			-10 to 22	V
$V_{GS,op}$	gate-source voltage			-5 to 18	V
P_{tot}	total power dissipation	T_{mb} = 25 °C		91	W
I_D	drain current	V_{GS} = 18 V; T_{mb} = 25 °C		7.5	A
		V_{GS} = 18 V; T_{mb} = 100 °C		5.3	A
I_{DM}	peak drain current	pulsed; t_p ≤ 10 μs; T_{mb} = 25 °C		20	A
E_{as}	single pulse drain−to-source avalanche	I_{AS} = 7 A; L = 1 mH; V_{DD} = 100 V; $T_{j(init)}$ = 25 °C		24.5	mJ
T_{stg}	storage temperature			-55 to 175	°C
T_j	junction temperature			-55 to 175	°C
$T_{sld(M)}$	peak soldering temperature			260	°C

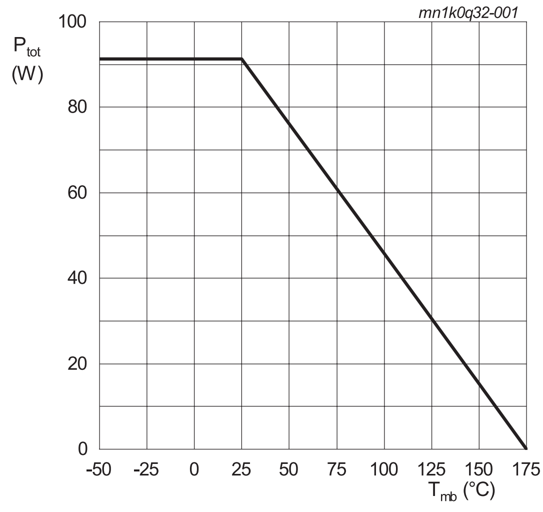


Fig. 1. Total power dissipation as a function of mounting base temperature; maximum values

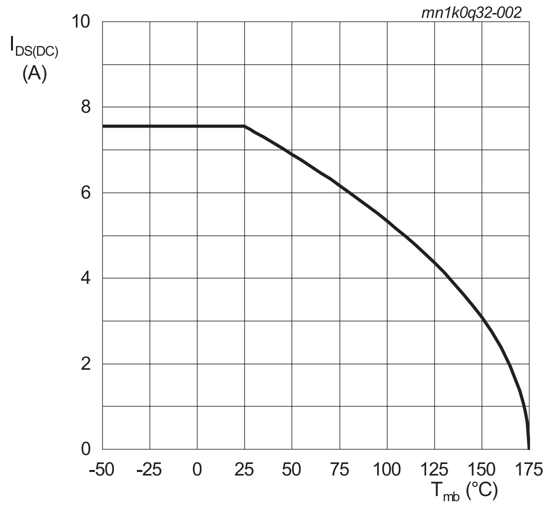


Fig. 2. Continuous Drain Current as a function of mounting base temperature

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base			-	-	1.64	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air		-	40	-	K/W

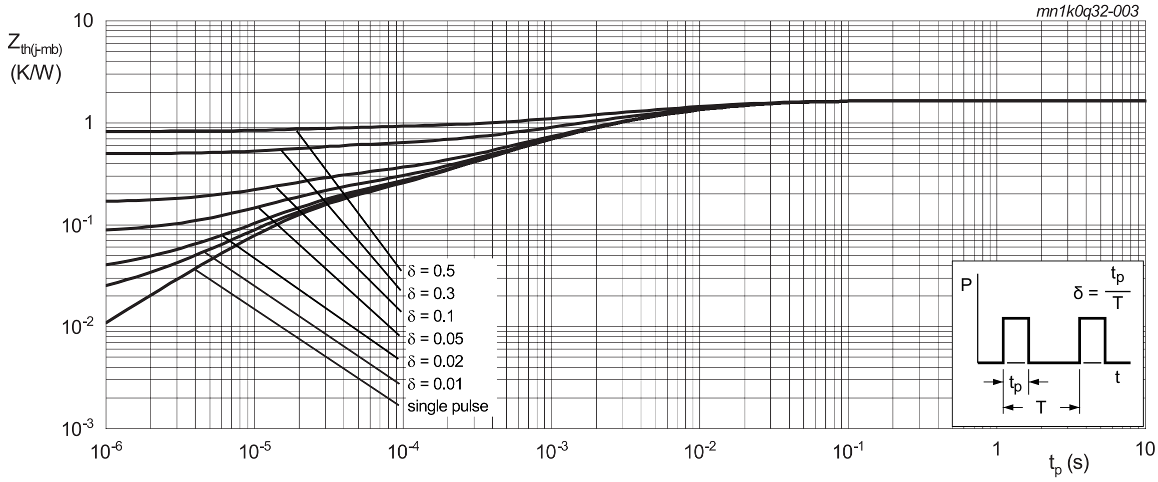
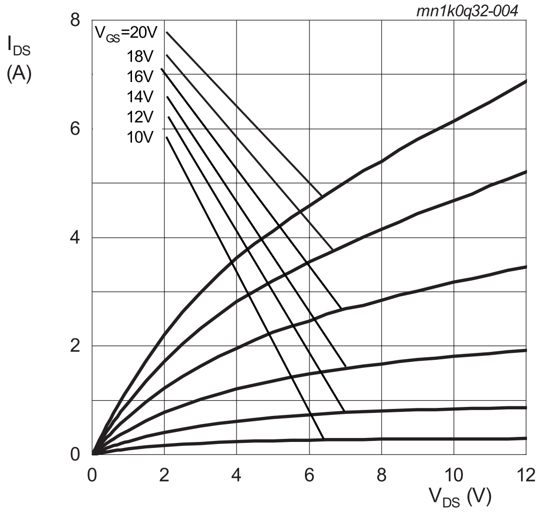


Fig. 3. Transient thermal impedance from junction to mounting base as a function of pulse duration

10. Characteristics

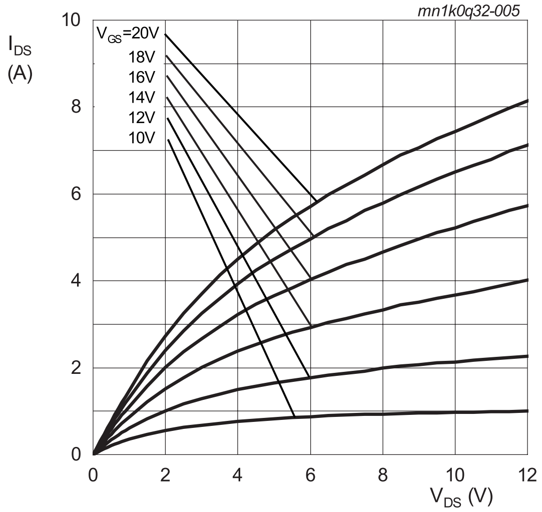
Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Static characteristics							
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 100 μA; V_{GS} = 0 V; T_j = 25 °C		1700	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 0.8 mA; V_{DS} = 10 V; T_j = 25 °C		2.3	3.2	4.2	V
		I_D = 0.8 mA; V_{DS} = 10 V; T_j = 150 °C		-	2.4	-	V
I_{DSS}	drain leakage current	V_{DS} = 1700 V; V_{GS} = 0 V; T_j = 25 °C		-	0.1	10	μA
		V_{DS} = 1700 V; V_{GS} = 0 V; T_j = 150 °C		-	1	-	μA
I_{GSS}	gate leakage current	V_{GS} = 18 V; V_{DS} = 0 V; T_j = 25 °C		-	10	100	nA
		V_{GS} = -10 V; V_{DS} = 0 V; T_j = 25 °C		-	10	100	nA
$R_{DS(on)}$	drain-source on-state resistance	V_{GS} = 15 V; I_D = 1 A; T_j = 25 °C		-	1000	-	mΩ
		V_{GS} = 18 V; I_D = 1 A; T_j = 25 °C		-	750	1000	mΩ
		V_{GS} = 18 V; I_D = 1 A; T_j = 150 °C		-	1050	-	mΩ
R_G	gate resistance	f = 1 MHz; T_j = 25 °C		-	16	-	Ω
g_{fs}	transconductance	V_{DS} = 10 V; I_D = 1 A; T_j = 25 °C		-	0.5	-	S
Dynamic characteristics							
$Q_{G(tot)}$	total gate charge	I_D = 2 A; V_{DS} = 1200 V; V_{GS} = 0 V/18 V; T_j = 25 °C		-	12	-	nC
Q_{GS}	gate-source charge			-	3.8	-	nC
Q_{GD}	gate-drain charge			-	5	-	nC
C_{iss}	input capacitance	V_{DS} = 1000 V; V_{GS} = 0 V; f = 1 MHz; T_j = 25 °C		-	225	-	pF
C_{oss}	output capacitance			-	15	-	pF
C_{rss}	reverse transfer capacitance			-	2.8	-	pF
E_{oss}	Coss stored energy			-	7.5	-	μJ
$t_{d(on)}$	turn-on delay time	V_{DS} = 1000 V; V_{GS} = -3 V/18 V; $R_{G(ext)}$ = 5.1 Ω; I_D = 2 A; L = 1.4 mH; T_j = 25 °C		-	15	-	ns
t_r	rise time			-	21	-	ns
$t_{d(off)}$	turn-off delay time			-	19	-	ns
t_f	fall time			-	10	-	ns
E_{on}	turn-on energy (Body Diode FWD)			-	23	-	μJ
E_{off}	turn-off energy (Body Diode FWD)			-	3	-	μJ
Source-drain diode							
V_{SD}	source-drain voltage	V_{GS} = 0 V; I_F = 1 A; T_j = 25 °C		-	3.9	-	V
		V_{GS} = 0 V; I_F = 1 A; T_j = 150 °C		-	3.4	-	V
t_{rr}	reverse recovery time	I_{SD} = 1 A; di/dt = 500 A/μs; V_{DS} = 400 V; T_j = 25 °C		-	36	-	ns
Q_r	recovered charge			-	38	-	nC
I_{rrm}	reverse recovery current			-	1.8	-	A



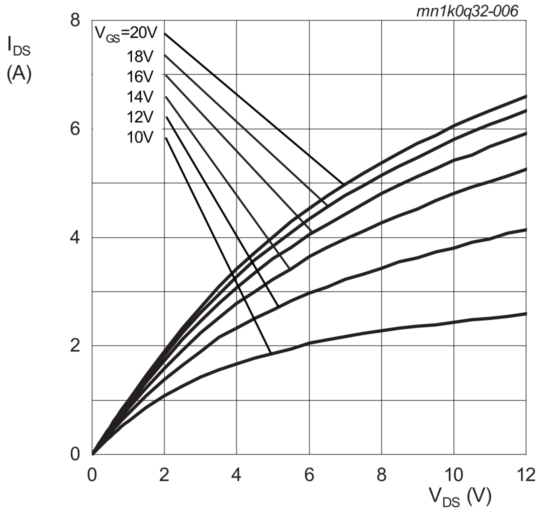
T_j = -55 °C; t_p < 200 µs

Fig. 4. Output characteristics; drain current as a function of drain-source voltage; typical values



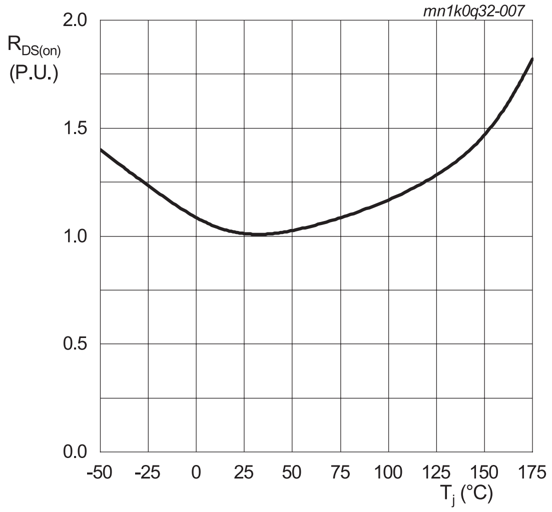
T_j = 25 °C; t_p < 200 µs

Fig. 5. Output characteristics; drain current as a function of drain-source voltage; typical values



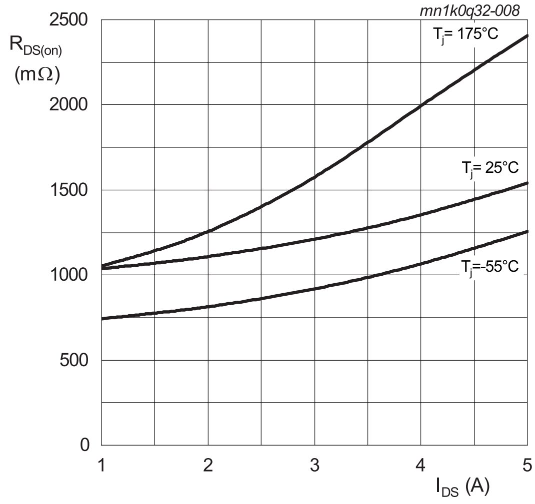
T_j = 150 °C; t_p < 200 µs

Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values



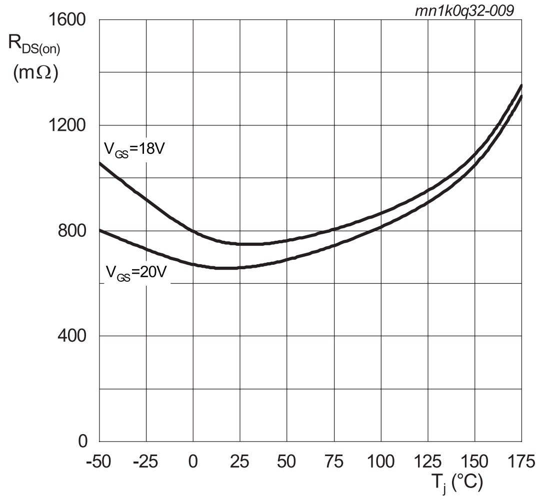
I_{DS} = 1 A; V_{GS} = 18 V; t_p < 200 µs

Fig. 7. Normalized drain-source on-state resistance as a function of junction temperature



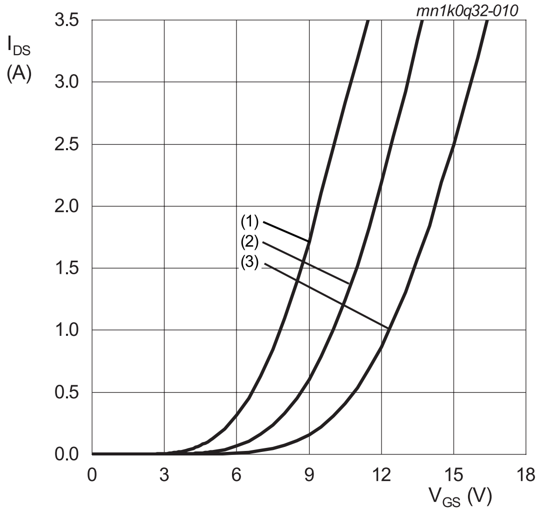
V_{GS} = 18 V; t_p < 200 µs

Fig. 8. Drain-source on-state resistance as a function of drain current; typical values



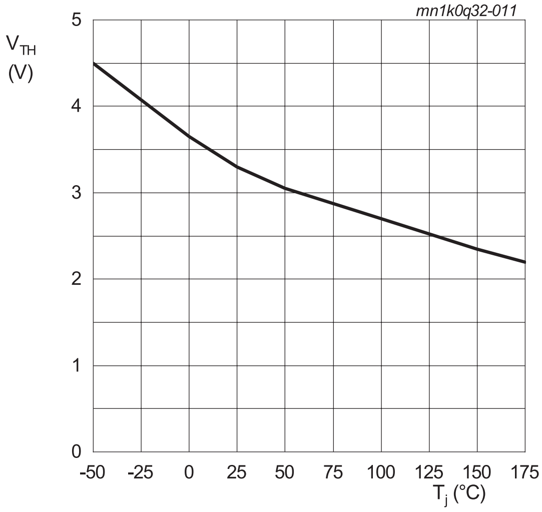
I_{DS} = 1 A; t_p < 200 µs

Fig. 9. Drain-source on-state resistance as a function of junction temperature



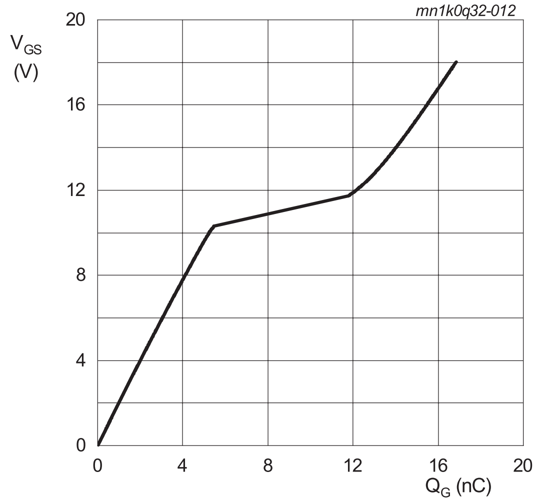
V_{DS} = 10 V; t_p < 200 µs
(1) T_j = 150 °C
(2) T_j = 25 °C
(3) T_j = -55 °C

Fig. 10. Transfer characteristics; drain current as a function of gate-source voltage; typical values



V_{DS} = 10 V; I_{DS} = 0.8 mA

Fig. 11. Threshold voltage as a function of junction temperature



I_{DS} = 2 A; I_{GS} = 0.1 mA; V_{DS} = 1200 V; T_j = 25 °C

Fig. 12. Gate-source voltage as a function of gate charge; typical values

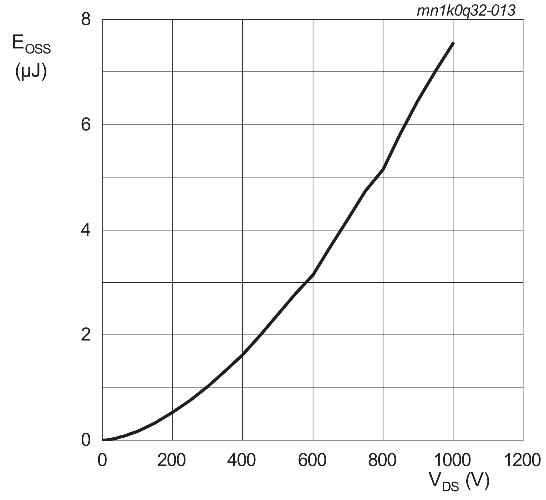
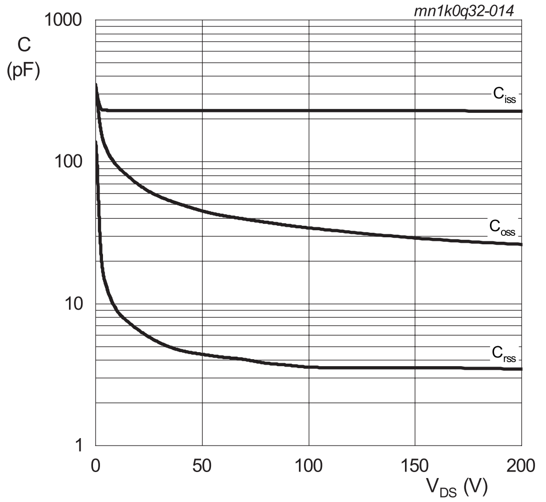


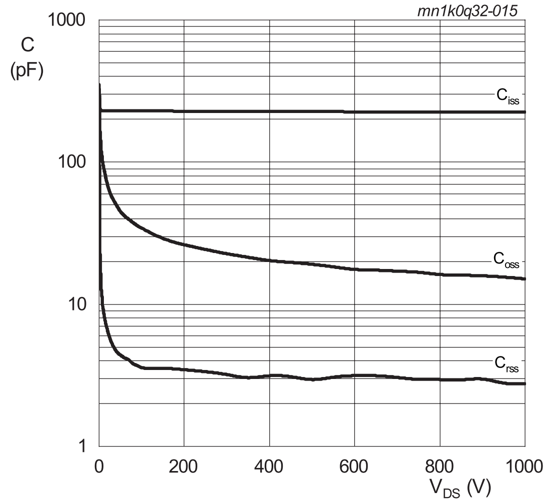
Fig. 13. Output capacitor stored energy as a function of drain-source voltage



V_{DS} = 0 - 200 V

T_j = 25 °C; V_{AC} = 25 mV; f = 1 MHz

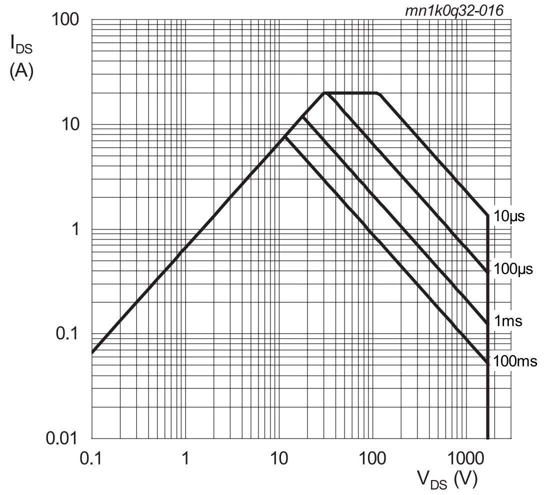
Fig. 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



V_{DS} = 0 - 1000 V

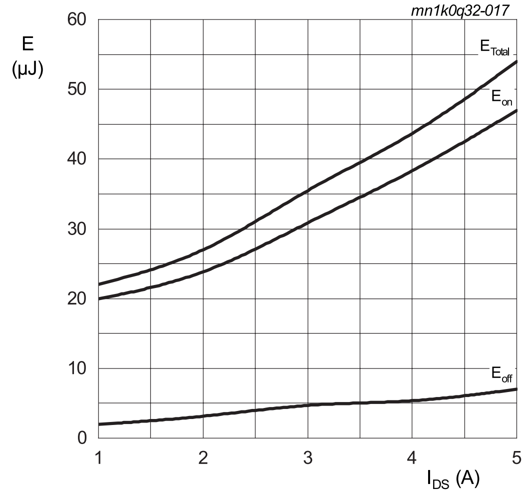
T_j = 25 °C; V_{AC} = 25 mV; f = 1 MHz

Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



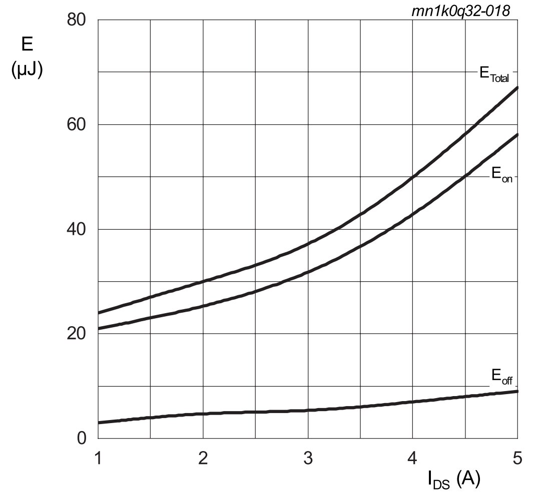
T_j = 25 °C; D = 0
Parameter: t_p

Fig. 16. Forward bias safe operating area



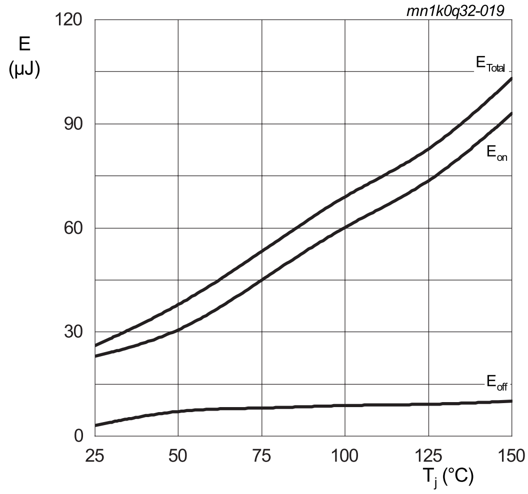
T_j = 25 °C; V_{DD} = 1000 V; $R_{G(ext)}$ = 5.1 Ω;
V_{GS} = -3 V/18 V; FWD = WNSC2M1K0170B7
L = 1.4 mH

Fig. 17. Clamped Inductive Switching Energy as a function of drain current



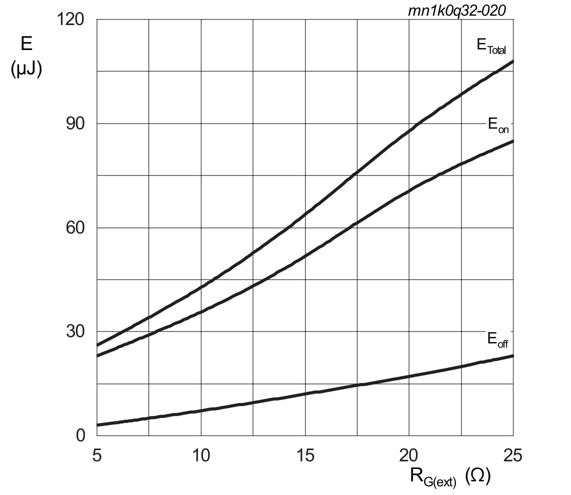
T_j = 25 °C; V_{DD} = 1200 V; $R_{G(ext)}$ = 5.1 Ω;
V_{GS} = -3 V/18 V; FWD = WNSC2M1K0170B7
L = 1.4 mH

Fig. 18. Clamped Inductive Switching Energy as a function of drain current



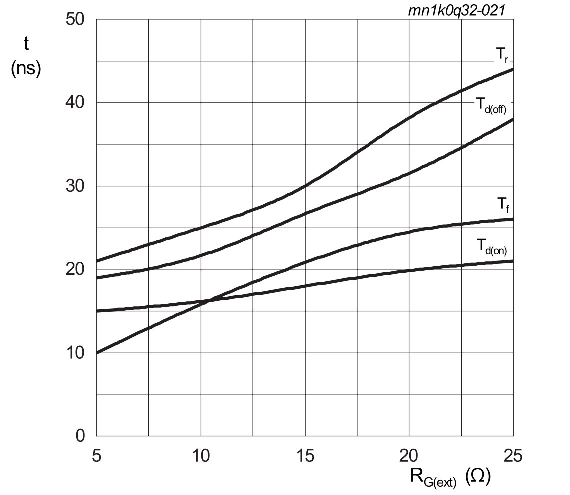
I_{DS} = 2 A; V_{DD} = 1000 V; $R_{G(ext)}$ = 5.1 Ω;
V_{GS} = -3 V/18 V; FWD = WNSC2M1K0170B7
L = 1.4 mH

Fig. 19. Clamped Inductive Switching Energy as a function of junction temperature



T_j = 25 °C; V_{DD} = 1000 V; I_{DS} = 2 A; V_{GS} = -3 V/18 V
FWD = WNSC2M1K0170B7; L = 1.4 mH

Fig. 20. Clamped Inductive Switching Energy as a function of external gate resistance



T_j = 25 °C; V_{DD} = 1000 V; I_{DS} = 2 A; V_{GS} = -3 V/18 V
FWD = WNSC2M1K0170B7; L = 1.4 mH

Fig. 21. Switching time as a function of external gate resistance

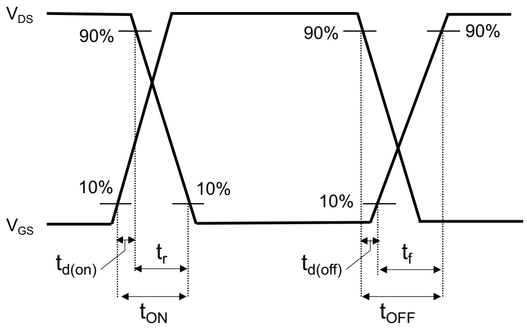
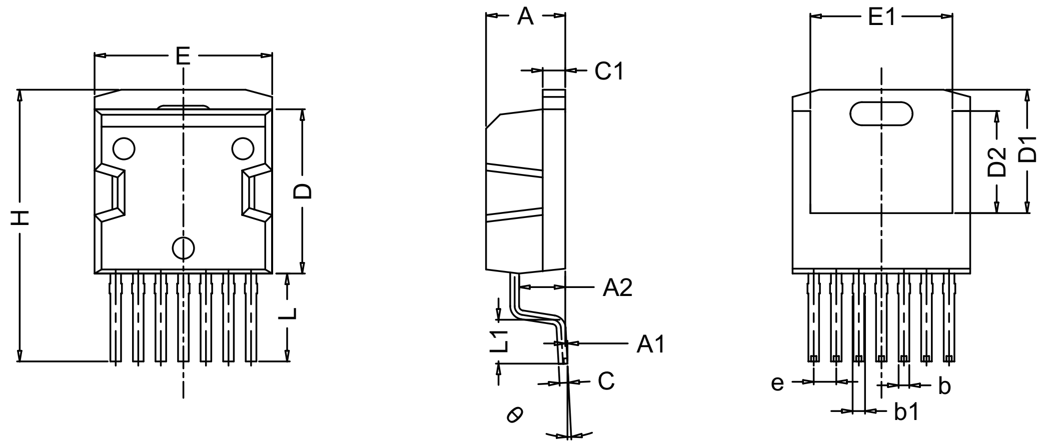


Fig. 22. Switching time definition

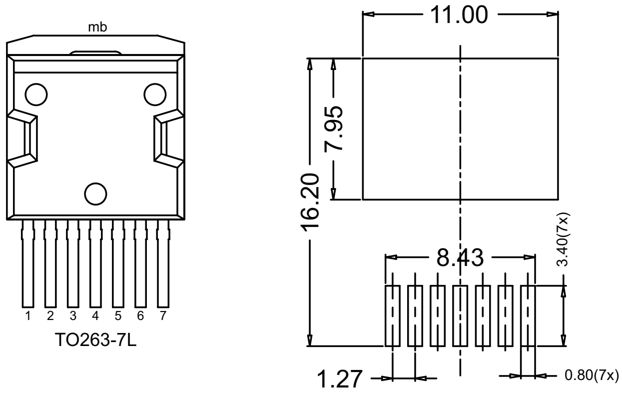
11. Package outline

Plastic single-ended surface-mounted package (D2PAK); 7 leads TO263-7L



Dim	All Dimensions in Millimters		
	Min	Typ	Max
A	4.30	4.46	4.60
A1	0	0.13	0.25
A2	2.50	2.60	2.70
b	0.50	0.60	0.70
b1	0.50	0.70	0.90
C	0.40	0.52	0.60
C1	1.17	1.29	1.40
D	9.00	9.25	9.50
D1	6.80	6.95	7.10
D2	5.60	5.75	5.90
E	9.80	10.00	10.20
E1	7.90	8.00	8.10
e	1.27		
H	14.60	15.30	16.00
L	4.50	4.95	5.40
L1	2.10	2.47	2.80
θ	0°	4°	8°

Footprint:



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.
[2] The term 'short data sheet' is explained in section "Definitions".
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13. Contents

For more information, please visit: http://www.ween-semi.com
For sales office addresses, please send an email to: salesaddresses@ween-semi.com
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